

L Number	Hits	Search Text	DB	Time stamp
6	0	(contour adj graph) same search\$3 same retriev\$3 same word	USPAT; EPO; JPO; DERWENT; IBM_TDB	2004/02/20 11:29
7	3	GRAPH SAME DOCUMENT SAME CONCEPT SAME INTEREST	USPAT; EPO; JPO; DERWENT; IBM_TDB	2004/02/20 11:30
8	0	(concept same interest) same thumbprint	USPAT; EPO; JPO; DERWENT; IBM_TDB	2004/02/20 11:31
9	111	(contour adj graph)	USPAT; EPO; JPO; DERWENT; IBM_TDB	2004/02/20 11:31
10	0	((contour adj graph)) same keyword	USPAT; EPO; JPO; DERWENT; IBM_TDB	2004/02/20 11:31
11	0	((contour adj graph)) same kwic	USPAT; EPO; JPO; DERWENT; IBM_TDB	2004/02/20 11:31
1	322	715/500.ccls.	USPAT	2004/02/20 11:32
2	744	715/529-531.ccls.	USPAT	2004/02/20 11:35
3	634	345/440.ccls.	USPAT	2004/02/20 11:36
4	181	345/684.ccls.	USPAT	2004/02/20 11:39
5	9	345/689.ccls.	USPAT	2004/02/20 11:39
-	0	graph same location same concentration same kwic	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/02/19 16:07
-	0	graph same location same concentration same keyword	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/02/19 16:21
-	7	graph same location same distribution same text	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/02/19 16:23
-	14	histogram same location same distribution same text	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/02/19 16:24
-	1	("5339391").PN.	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/02/20 07:07

	Document ID	Issue Date	Title	Current OR	Inventor	Image Doc. Displayed	PT
1	US 20030076989 A1	20030424	Automated repetitive array microstructure defect inspection	382/145	Maayah, Kais Jameel et al.	US 20030076989	<input type="checkbox"/>
2	US 20020131651 A1	20020919	System and method for reducing images including graphs	382/284	Anantharamu, Chandrashekhara et al.	US 20020131651	<input type="checkbox"/>
3	US 20010049671 A1	20011206	e-Stract: a process for knowledge-based retrieval of electronic information	706/50	Joerg, Werner B.	US 20010049671	<input type="checkbox"/>
4	US 6691259 B1	20040210	Terminal server data file extraction and analysis application	714/46	Mackey, Kyle Joseph James et al.	US 6691259	<input type="checkbox"/>
5	US 6567767 B1	20030520	Terminal server simulated client performance measurement tool	702/186	Mackey, Kyle Joseph James et al.	US 6567767	<input type="checkbox"/>
6	US 5867597 A	19990202	High-speed retrieval by example	382/209	Peairs, Mark et al.	US 5867597	<input type="checkbox"/>
7	NN7208834	19720801	Computer Generation of 3D Pictures. August 1972.			NN7208834	<input type="checkbox"/>

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1	US 20030076989 A1	20030424	Automated repetitive array microstructure defect inspection	382/145	Maayah, Kais Jameel et al.	US 20030076989	<input type="checkbox"/>
2	US 20030049653 A1	20030313	Method for serial analysis of gene expression	435/6	Kinzler, Kenneth W. et al.	US 20030049653	<input type="checkbox"/>
3	US 20030008290 A1	20030109	Serial analysis of transcript expression using long tags	435/6	Velculescu, Victor E. et al.	US 20030008290	<input type="checkbox"/>
4	US 6565003 B1	20030520	Method for locating and reading a two-dimensional barcode	235/462.1	Ma, Yue	US 6565003	<input type="checkbox"/>
5	US 6498013 B1	20021224	Serial analysis of transcript expression using MmeI and long tags	435/6	Velculescu, Victor E. et al.	US 6498013	<input type="checkbox"/>
6	US 6383743 B1	20020507	Method for serial analysis of gene expression	435/6	Kinzler, Kenneth W. et al.	US 6383743	<input type="checkbox"/>
7	US 6082619 A	20000704	Method for locating and reading a two-dimensional barcode	235/462.1	Ma, Yue et al.	US 6082619	<input type="checkbox"/>
8	US 5867597 A	19990202	High-speed retrieval by example	382/209	Peairs, Mark et al.	US 5867597	<input type="checkbox"/>
9	US 5866330 A	19990202	Method for serial analysis of gene expression	435/6	Kinzler, Kenneth W. et al.	US 5866330	<input type="checkbox"/>

	Document ID	Issue Date	Title	Current OR	Inventor	Image Doc. Displayed	PT
10	US 5828771 A	19981027	Method and article of manufacture for determining whether a scanned image is an original image or fax image	382/112	Bloomberg, Dan S.	US 5828771	<input type="checkbox"/>
11	US 5425110 A	19950613	Method and apparatus for automatic language determination of Asian language documents	382/192	Spitz, A. Lawrence	US 5425110	<input type="checkbox"/>
12	US 5257206 A	19931026	Statistical process control for air separation process	700/273	Hanson, Thomas C.	US 5257206	<input type="checkbox"/>
13	US 4656665 A	19870407	Thresholding technique for graphics images using histogram analysis	382/172	Pennebaker, William B.	US 4656665	<input type="checkbox"/>
14	NN8804405	19880401	Automated Inspection Microscope			NN8804405	<input type="checkbox"/>